



# AOD410

## N-Channel Enhancement Mode Field Effect Transistor

General Description			Features		
The AOD410 uses advanced trench technology to provide excellent R <sub>DS(ON)</sub> and low gate charge. This device is suitable for use as a load switch or in PWM applications. -RoHS Compliant -Halogen Free*			$\begin{split} V_{DS} & (V) = 30V \\ I_{D} = 8A \; (V_{GS} = 10V) \\ R_{DS(ON)} < 65m\Omega  (V_{GS} = 10V) \\ R_{DS(ON)} < 105m\Omega \; (V_{GS} = 4.5V) \end{split}$		
			100% UIS Tested! 100% Rg Tested!		
Top Vie	TO-252 D-PAK Bottom View				
	G S S	G	G		
	Ratings T <sub>A</sub> =25°C unless			Units	
Parameter	Ratings T <sub>A</sub> =25°C unless	Symbol	oted Maximum 30	Units V	
<b>Parameter</b> Drain-Source Voltage	Ratings T <sub>A</sub> =25°C unless	Symbol V <sub>DS</sub>	Maximum		
<b>Parameter</b> Drain-Source Voltage Gate-Source Voltage	Ratings T <sub>A</sub> =25°C unless	Symbol	Maximum 30	V	
<b>Parameter</b> Drain-Source Voltage Gate-Source Voltage Continuous Drain	Ratings T <sub>A</sub> =25°C unless e T <sub>C</sub> =25°C	Symbol V <sub>DS</sub>	Maximum 30 ±20	V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup>	Ratings $T_A=25^{\circ}C$ unless e T_C=25^{\circ}C T_C=100^{\circ}C	Symbol V <sub>DS</sub> V <sub>GS</sub>	Maximum       30       ±20       8	V V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup> Pulsed Drain Current	Ratings $T_A = 25^{\circ}C$ unless   e N   e N   T_C = 25^{\circ}C N   T_C = 100^{\circ}C I	Symbol V <sub>DS</sub> V <sub>GS</sub>	Maximum       30       ±20       8       6	V V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup> Pulsed Drain Current Avalanche Current <sup>C</sup>	Ratings $T_A = 25^{\circ}C$ unless   e N   e N   T_C = 25^{\circ}C N   T_C = 100^{\circ}C I   t B I	Symbol V <sub>DS</sub> V <sub>GS</sub> D D AR	Maximum       30       ±20       8       6       20	V V A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup> Pulsed Drain Current Avalanche Current <sup>C</sup>	Ratings $T_A = 25^\circ C$ unless     e   N     e   N     T_C = 25^\circ C   T     T_C = 100^\circ C   I     t B   I     e energy L=0.1mH <sup>C</sup> I     T_C = 25^\circ C   I	Symbol V <sub>DS</sub> V <sub>GS</sub> D D AR E <sub>AR</sub>	Maximum       30       ±20       8       6       20       8       8	V V A A M M J	
Absolute Maximum Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup> Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche Power Dissipation <sup>B</sup>	Ratings $T_A = 25^\circ C$ unless     e   N     e   N     T_C = 25^\circ C   T     T_C = 100^\circ C   I     t B   I     e energy L=0.1mH <sup>C</sup> I     T_C = 25^\circ C   I	Symbol V <sub>DS</sub> V <sub>GS</sub> D D AR	Maximum       30       ±20       8       6       20       8       10	V V A A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup> Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unlesseYT_C=25^{\circ}CT_C=100^{\circ}Ct Be energy L=0.1mH cET_C=25^{\circ}CT_C=100^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}C	Symbol V <sub>DS</sub> V <sub>GS</sub> D D D AR E <sub>AR</sub> P <sub>D</sub>	Maximum       30       ±20       8       6       20       8       10       25	V V A A mJ W	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current <sup>G</sup> Pulsed Drain Current Avalanche Current <sup>C</sup> Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unlesseYT_C=25^{\circ}CT_C=100^{\circ}Ct Be energy L=0.1mH cET_C=25^{\circ}CT_C=100^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}CT_C=100^{\circ}CT_C=25^{\circ}C	Symbol V <sub>DS</sub> V <sub>GS</sub> D D AR E <sub>AR</sub>	Maximum       30       ±20       8       6       20       8       10       25       12.5	V V A A M M J	

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	R <sub>0JA</sub>	20	30	°C/W			
Maximum Junction-to-Ambient A	Steady-State	Γ <sub>θJA</sub>	46	60	°C/W			
Maximum Junction-to-Case <sup>C</sup>	Steady-State	$R_{ ext{ hetaJL}}$	5.3	7	°C/W			



#### Electrical Characteristics (Tj=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V		30			V
	Zero Gate Voltage Drain Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V				1	μA
			T <sub>J</sub> =55°C			5	μΑ
I <sub>GSS</sub>	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V				100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}$ I <sub>D</sub> =250µA		1	1.8	3	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =4.5V, $V_{DS}$ =5V		10			Α
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =8A			48	65	mΩ
			T <sub>J</sub> =125°C		76	100	
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =2A			75	105	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =8A			6.2		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =1A,V <sub>GS</sub> =0V			0.75	1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Current					4.3	Α
DYNAMI	C PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			288		pF
C <sub>oss</sub>	Output Capacitance				57		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				39		pF
R <sub>g</sub>	Gate resistance				3		Ω
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =8A			6.72		nC
Q <sub>g</sub> (4.5V)	Total Gate Charge				3.34		nC
Q <sub>gs</sub>	Gate Source Charge				0.76		nC
$Q_{gd}$	Gate Drain Charge				1.78		nC
t <sub>D(on)</sub>	Turn-On DelayTime	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =1.8 $\Omega$ , $R_{GEN}$ =3 $\Omega$			3.7		ns
t <sub>r</sub>	Turn-On Rise Time				3.7		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				15.6		ns
t <sub>f</sub>	Turn-Off Fall Time				2.6		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =8A, dl/dt=100A/μs			12.6		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charg	e I <sub>F</sub> =8A, dI/dt=100A/μs			5.1		nC

A: The value of  $R_{0JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$ C. The Power dissipation  $P_{DSM}$  is based on R <sub>0JA</sub> and the maximum allowed junction temperature of 150°C. The value in any a given application depends on the user's specific board design, and the maximum temperature for 175°C may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =175°C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedence from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu s$  pulses, duty cycle 0.5% max.

F. These tests are performed with the device mounted on 1 in  $^2$  FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

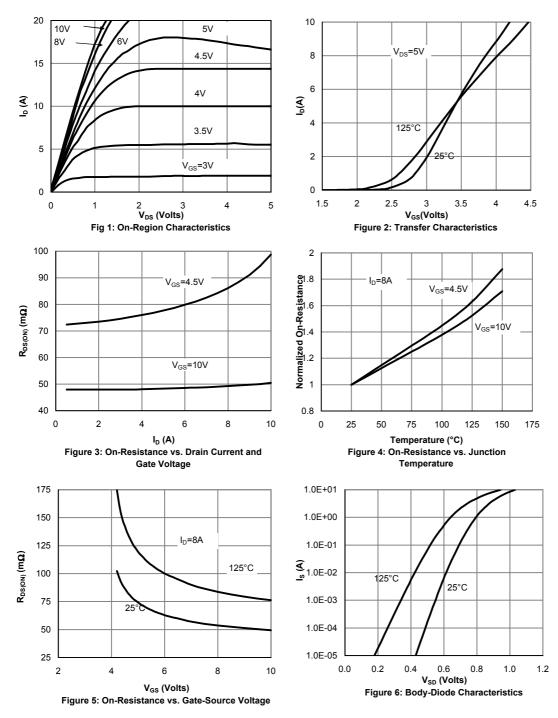
G. The maximum current rating is limited by bond-wires.

\*This device is guaranteed green after data code 8X11 (Sep  $1^{ST}$  2008).

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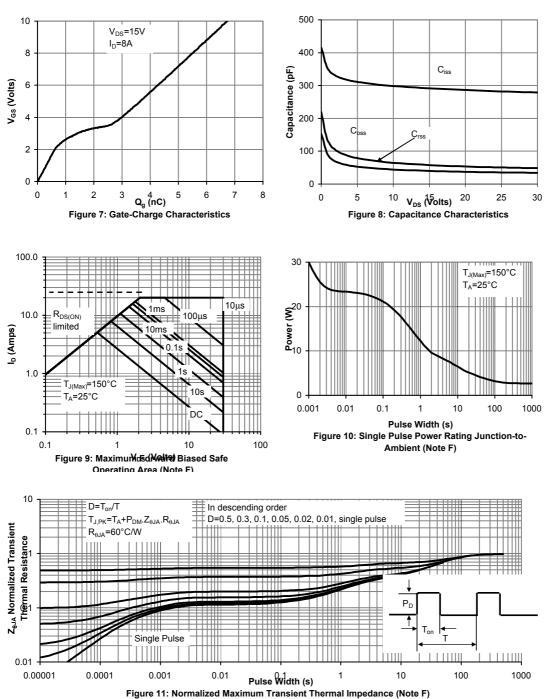
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### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

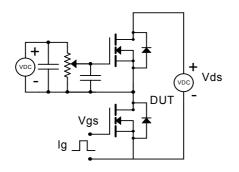


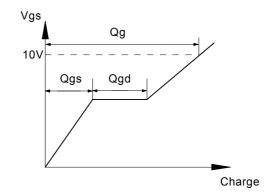


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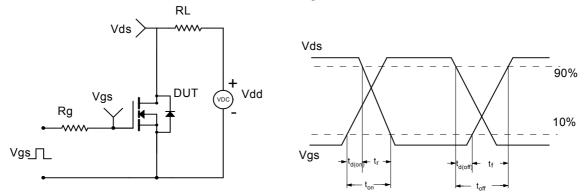


## Gate Charge Test Circuit & Waveform

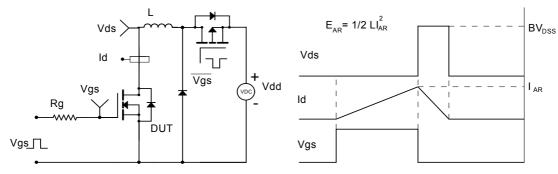




Resistive Switching Test Circuit & Waveforms



## Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



## Diode Recovery Test Circuit & Waveforms

